MT3117/B

N-Channel 125V/170A Power MOSFET

Features

- Typ R_{DS} (on)=6.3 m_{Ω} / V_{GS} =10V, I_{D} =85A
- · Fast Switching Speed
- · Low Gate Charge
- · 100% avalanche tested

General Description

This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for low gate charge, low RDS(ON) and fast switching speed.

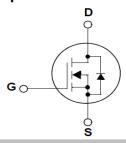
Applications

- DC-DC primary bridge
- · DC-DC Synchronous rectification
- · Power Managemement for Inverter Systems

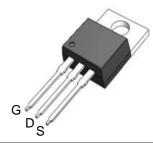


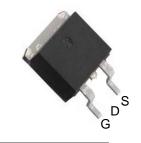
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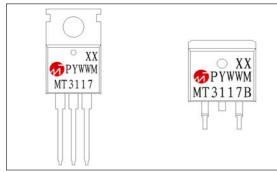
Simplified Schematic



MARKING DIAGRAM & PIN ASSIGNMENT







Package Code

MT3117: T0-220FB-3L MT3117B: T0-263-2L

Date Code

Lot No

Absolute Maximum Ratings

Symbol	Parameter	Rating	Unit			
Common Ratings (T _c =25°C Unless Otherwise Noted)						
V _{DSS}	Drain-Source Voltage	125	\ \			
V_{GSS}	Gate-Source Voltage	±25	\ \ \ \ \ \			
T_J	Maximum Junction Temperature	175	°C			
T_{STG}	Storage Temperature Range	-55 to 175	°C			
Is	Diode Continuous Forward Current	170	Α			

Mounted on Large Heat Sink

I _{DM}	Pulsed Drain Current * T _C =25°C		585**	Α			
I _D	Continuous Drain Current	T _C =25°C	170	A			
	Continuous Brain Current	T _C =100°C	124				
P _D	Maximum Power Dissipation	T _C =25°C	339	W			
	Maximum Fower Dissipation	T _C =100°C	170				
$R_{ heta JC}$	Thermal Resistance-Junction to Case	0.44	°C/W				
$R_{\theta JA}$	Thermal Resistance-Junction to Ambient	62.5					
Avalanche Ratings							
E _{AS}	Avalanche Energy, Single Pulsed L=0.5mH		1155***	mJ			

Note: * Repetitive rating; pulse width limited by junction temperature
** Drain current is limited by junction temperature

Electrical Characteristics $(T_c = 25^{\circ}C \text{ Unless Otherwise Noted})$

Symbol	Parameter	Test Conditions				
Symbol	Faranietei	rest Conditions	Min.	Тур.	Max.	Unit
Static Cha	racteristics	•	,			
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _{DS} =250μA	125	-	-	V
	Zara Cata Valtaga Brain Current	V _{DS} =125V, V _{GS} =0V	-	-	1	μА
I _{DSS}	Zero Gate Voltage Drain Current	T _J =85°C	-	-	10	
V _{GS(th)}	Gate Threshold Voltage	$V_{DS}=V_{GS}$, $I_{DS}=250\mu A$	2.0	3.0	4.0	V
I _{GSS}	Gate Leakage Current	V_{GS} =±25V, V_{DS} =0V	-	-	±100	nA
R _{DS(ON)} *	Drain-Source On-state Resistance	V _{GS} =10V, I _{DS} =85A	-	6.3	7.5	mΩ
Diode Cha	aracteristics	•	,		,	
V _{SD} *	Diode Forward Voltage	I _{SD} =85A, V _{GS} =0V	-	0.8	1	V
t _{rr}	Reverse Recovery Time	1 -054 dl /dt=1004/ug	-	70	-	ns
Q _{rr}	Reverse Recovery Charge	I _{SD} =85A, dI _{SD} /dt=100A/μs	-	110	-	nC

2

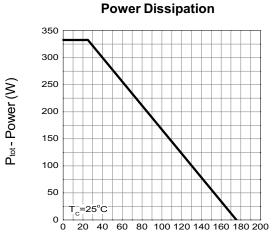
^{***} VD=100V

Electrical Characteristics (Cont.) $(T_c = 25^{\circ}C \text{ Unless Otherwise Noted})$

Symbol	Parameter	Test Conditions				Unit		
Syllibol	Farameter	rest Conditions	Min.	Тур.	Max.	Ullit		
Dynamic (Dynamic Characteristics							
R_{G}	Gate Resistance	V _{GS} =0V,V _{DS} =0V,F=1MHz	-	3.0	-	Ω		
C _{iss}	Input Capacitance	V _{GS} =0V,	_	8162	-	pF		
C _{oss}	Output Capacitance	V _{DS} =25V,	-	980	-			
C _{rss}	Reverse Transfer Capacitance	Frequency=1.0MHz	-	509	-			
t _{d(ON)}	Turn-on Delay Time		-	35	-			
Tr	Turn-on Rise Time	V_{DD} =62.5 V, R_{G} = 6 Ω , I_{DS} =85A, V_{GS} =10V,	_	46	-	ne		
t _{d(OFF)}	Turn-off Delay Time	IDS -03A, VGS-10V,	-	95	-	ns		
T _f	Turn-off Fall Time		-	52	-			
Gate Charge Characteristics								
Q_g	Total Gate Charge		-	189	-			
Q_gs	Gate-Source Charge	V_{DS} =100V, V_{GS} =10V, V_{DS} =85A	_	29	_	nC		
Q_{gd}	Gate-Drain Charge		-	70	-			

Note * : Pulse test ; pulse width ≤300µs, duty cycle≤2%.

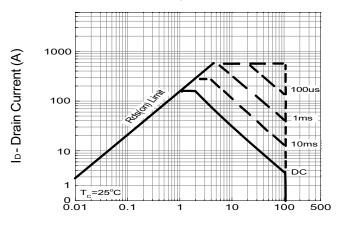
Typical Operating Characteristics



T_c- Case Temperature (°C)

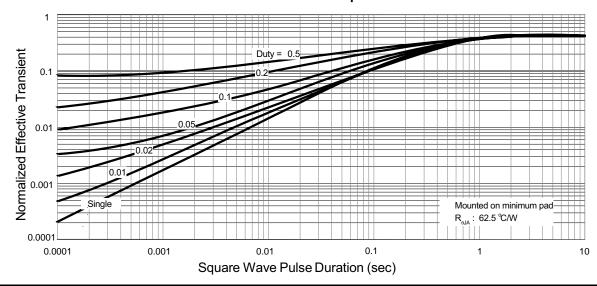
T_c-Case Temperature (°C)

Safe Operation Area



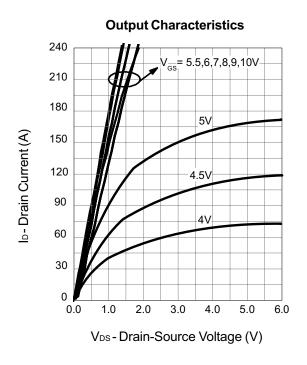
V_{DS} - Drain - Source Voltage (V)

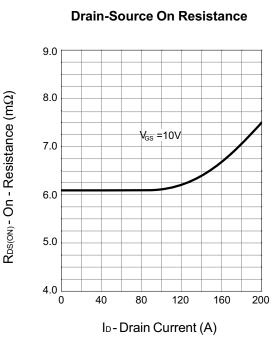
Thermal Transient Impedance



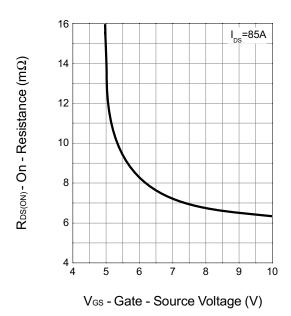
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Typical Operating Characteristics (Cont.)

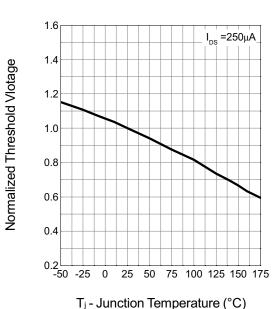




Drain-Source On Resistance

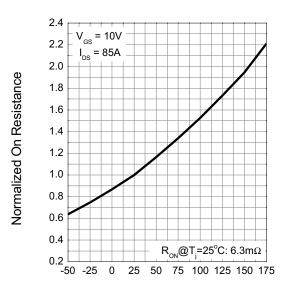


Gate Threshold Voltage



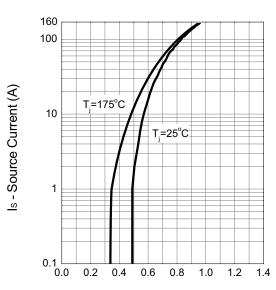
Typical Operating Characteristics (Cont.)

Drain-Source On Resistance



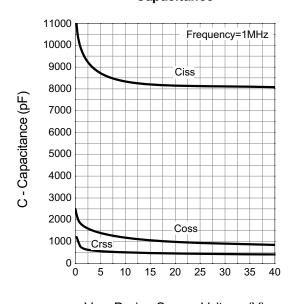
T_j- Junction Temperature (°C)

Source-Drain Diode Forward



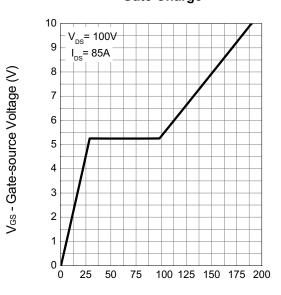
VsD - Source-Drain Voltage (V)

Capacitance



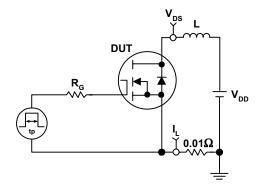
V_{DS} - Drain - Source Voltage (V)

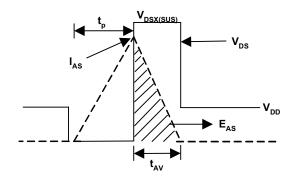
Gate Charge



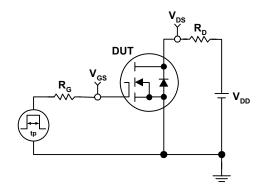
Q_G - Gate Charge (nC)

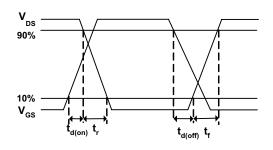
Avalanche Test Circuit and Waveforms



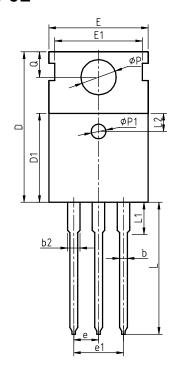


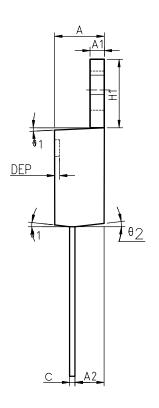
Avalanche Test Circuit and Waveforms



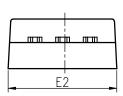


Package Information TO-220FB-3L



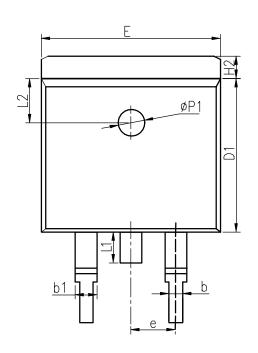


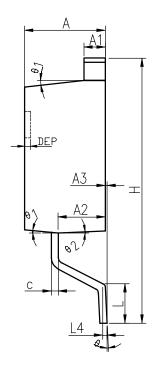
COMMON DIMENSIONS



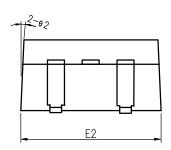
SYMBOL	MIN	NOM	MAX	MIN	NOM	MAX
A	4.40	4. 57	4. 70	0.173	0. 180	0. 185
A1	1.27	1.30	1. 33	0.050	0.051	0.052
A2	2.35	2. 40	2. 50	0.093	0.094	0. 098
b	0.77	0.80	0.90	0.030	0.031	0.035
b2	1.17	1. 27	1. 36	0.046	0.050	0.054
С	0.48	0.50	0. 56	0.019	0.020	0.022
D	15. 40	15.60	15.80	0.606	0.614	0.622
D1	9.00	9. 10	9. 20	0.354	0.358	0. 362
DEP	0.05	0. 10	0. 20	0.002	0.004	0.008
Е	9.80	10.00	10.20	0.386	0.394	0.402
E1	-	8. 70	-	-	0.343	ı
E2	9.80	10.00	10.20	0.386	0.394	0.402
е		2. 54	BSC		0.100	BSC
e1		5. 08	BSC		0.200	BSC
H1	6.40	6. 50	6.60	0. 252	0. 256	0.260
L	12.75	13. 50	13.65	0.502	0. 531	0.537
L1	ı	3. 10	3.30	ı	0. 122	0.130
L2		2.50	REF		0.098	REF
Р	3. 50	3. 60	3. 63	0. 138	0. 142	0.143
P1	3. 50	3. 60	3. 63	0. 138	0. 142	0.143
Q	2.73	2.80	2.87	0. 107	0. 110	0.113
θ 1	5°	7°	9°	5°	7°	9°
θ2	1°	3°	5°	1°	3°	5°
θ3	1°	3°	5°	1°	3°	5°

TO-263-2L





COMMON DIMENSIONS



SYMBOL	MM			INCH			
STIVIDUL	MIN	NOM	MAX	MIN	NOM	MAX	
Α	4.40	4.57	4.70	0.173	0.180	0.185	
A1	1.22	1.27	1.32	0.048	0.050	0.052	
A2	2.59	2.69	2.79	0.102	0.106	0.110	
A3	0.00	0.10	0.20	0.000	0.004	0.008	
b	0.77	0.813	0.90	0.030	0.032	0.035	
b1	1.20	1.270	1.36	0.047	0.050	0.054	
С	0.34	0.381	0.47	0.013	0.015	0.019	
D1	8.60	8.70	8.80	0.339	0.343	0.346	
E	10.00	10.16	10.26	0.394	0.400	0.404	
E2	10.00	10.10	10.20	0.394	0.398	0.402	
е		2.54	BSC		0.100 BSC		
Н	14.70	15.10	15.50	0.579	0.594	0.610	
H2	1.17	1.27	1.40	0.046	0.050	0.055	
L	2.00	2.30	2.60	0.079	0.091	0.102	
L1	1.45	1.55	1.70	0.057	0.061	0.067	
L2		2.50	REF		0.098	REF	
L4		0.25	BSC	0.010 BSC			
	0°	5°	8°	0°	5°	8°	
1	5°	7°	9°	5°	7°	9°	
2	1°	3°	5°	1°	3°	5°	
ФР1	1.40	1.50	1.60	0.055	0.059	0.063	
DEP	0.05	0.10	0.20	0.002	0.004	0.008	

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